

**Search Notes**

Application/Control No.

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Examiner

Leigh C. Maier

Applicant(s)/Patent under  
Reexamination

SHINKAI ET AL.

Art Unit

1623

**SEARCHED**

Class	Subclass	Date	Examiner
558	240-243 246 250 254-258	6/29/2006	LCM
564	84 154	6/29/2006	LCM
564	166	6/29/2006	LCM
564	188-191	6/29/2006	LCM
search	updated	12/22/2006	LCM
564	123	12/22/2006	LCM
514	613	12/22/2006	LCM

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
-STN structure seach	6/29/2006	LCM